

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
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UDAY SHAH)
MATTHEW V. METZ)
ROBERT S. CHAU)
ROBERT B. TURKOT, JR.)
Serial No.: unknown) Art Unit: unknown
Filed: unknown) Examiner: unknown
For: A METHOD FOR ETCHING) Attorney Docket: P17821
A THIN METAL LAYER)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

This Information Disclosure Statement is being submitted under 37 C.F.R. §1.97(b). Enclosed is a copy of Information Disclosure Citation Form PTO-1449 together with copies of the references cited on that form. It is respectfully requested that the cited references be considered and that the enclosed copy of Information Disclosure Citation Form PTO-1449 be initialed by the Examiner to indicate such consideration and a copy thereof returned to applicant(s).

Pursuant to 37 C.F.R. § 1.97, the submission of this Information Disclosure Statement is not to be construed as a representation that a search has been made

Form PTO-1449 (Modified)		Atty Docket No.: 42P17821		Serial No.: Unknown			
List of Patents and Publications Statement (Use several sheets if necessary)				Applicant: Justin K. Brask et al.			
				Filing Date : Herewith			
REFERENCE DESIGNATION			U.S. PATENT DOCUMENTS				
Examiner Initials		Document No.		Class	Sub-Class	Filing date if appropriate	
	AA	5,625,217	Chau et al.	257	412		
	AB	5,753,560	Hong et al.	438	402		
	AC	5,783,478	Chau et al.	438	592		
	AD	5,891,798	Doyle et al.	438	624		
	AE	6,063,698	Tseng et al.	438	585		
	AF	6,087,261	Nishikawa et al.	438	685		
	AG	6,121,094	Gardner et al.	438	287		
	AH	6,184,072	Kaushik et al.	438	197		
	AI	6,306,742 B1	Doyle et al.	438	591		
	AJ	6,391,802 B1	Delpech et al.	438	785		
	AK	6,420,279	Ono et al.	438	785		
	AL	6,436,777	Ota	438	305		
	AM	6,475,874	Xiang et al.	438	396		
	AN	6,514,828	Ahn et al.	438	240		
	AQ	6,544,906	Rotondaro et al.	438	785		
	AP	6,617,209	Chau et al.	438	240		
	AQ	6,617,210	Chau et al.	438	240		
	AR	US2002/0197790	Kizilyalli et al.	438	240		
	AS	US2003/0032303	Yu et al.	438	770		
FOREIGN PATENT DOCUMENTS							
		Document No.	Date	Country	Class	Sub-Class	Translation
	AT						
	AU						
OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)							
	AV	Polishchuk et al. "Dual Workfunction CMOS Gate Technology Based on Metal Interdiffusion," www.eesc.berkeley.edu , 1 page					
	AW	Doug Barlage et al., "High-Frequency Response of 100nm Integrated CMOS Transistors with High-K Gate Dielectrics", 2001 IEEE, 4 pages.					
	AX	Robert Chau et al., "A 50nm Depleted-Substrate CMOS Transistor (DST), 2001 IEEE, 4 pages.					
	AY	Lu et al., "Dual-Metal Gate Technology for Deep-Submicron CMOS Devices", dated April 29, 2003, 1 page.					
	AZ	Schwantes et al., "Performance Improvement of Metal Gate CMOS Technologies with Gigabit Feature Sizes", Technical University of Hanburg-Harburg, 5 pages.					
	BA	Parker et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/285,915, Filed October 31, 2002					
	BB	Chau et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/288,043, Filed November 5, 2002					
	BC	Parker et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/315,268, Filed December 10, 2002					
	BD	Doczy et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/338,174, Filed January 7, 2003					
	BE	Brask et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/387,303, Filed March 11, 2003					

	BF	Brask et al., "A Method of Making Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/391,816, Filed March 18, 2003
	BG	Chau et al., "A Method for Making a Semiconductor Device Having a Metal Gate Electrode", Serial No. 10/431,166, Filed May 6, 2003
	BH	Brask, et al, "A Method for Making a Semiconductor Device Having a High-K Gate Dielectric", Serial No. 10/441,616, filed May 20, 2003
	BI	Brask et al. "A Selective Etch Process for Making a Semiconductor Device Having a High-K Gate Dielectric," Serial No. 10/652,546, filed August 28, 2003
	BJ	Brask et al. "A Method for Making a Semiconductor Device Having a High-K Gate Dielectric," Serial No. 10/642,796, filed August 28, 2003
	BK	Brask, "Methods and Compositions for Selectively Etching Metal Films and Structures," Serial No. 10/658,225, filed September 8, 2003
Examiner		Date Considered
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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